

Silicon Carbide MOSFET N-Channel Enhancement Mode

 V_{DS} = 1200 V $R_{DS(ON)(Typ.)}$ = 12 mΩ $I_{D}(T_{C} = 100^{\circ}C)$ = 122 A

Features

- G3R™ (3rd Generation) Technology
- Softer R_{DS(ON)} v/s Temperature Dependency
- LoRing[™] Electromagnetically Optimized Design
- Smaller R_{G(INT)} and Lower Q_G
- Low Device Capacitances (Coss, Crss)
- Superior Cost-Performance Index
- Robust Body Diode with Low V_F and Low Q_{RR}
- Industry-Leading UIL & Short-Circuit Robustness

Bare Chip G KS D = Drain G = Gate S = Source KS = Kelvin Source

Advantages

- Compatible with Commercial Gate Drivers
- Low Conduction Losses at all Temperatures
- Reduced Ringing
- Faster and More Efficient Switching
- Lesser Switching Spikes and Lower Losses
- Better Power Density and System Efficiency
- Ease of Paralleling without Thermal Runaway
- Higher System Reliability

Applications

- EV Traction Inverters
- Industrial Motor Drives
- Solar Inverters
- Off-Board Chargers
- Solid State Circuit Breakers
- Switched Mode Power Supplies
- Pulsed Power

Absolute Maximum Ratings (At T _C = 25°C Unless Otherwise Stated)								
Parameter	Symbol	Conditions	Values	Unit	Note			
Drain-Source Voltage	$V_{DS(max)}$	V_{GS} = 0 V, I_D = 100 μA	1200	V				
Gate-Source Voltage (Dynamic)	$V_{GS(max)}$		-10 / +22	V				
Gate-Source Voltage (Static)	$V_{GS(op)-ON}$	Recommended Operation	+15 to +18	V				
Gate-Source voitage (Static)	V _{GS(op)-0FF}	neconfinencea operation	-5 to -3	V				
		$T_C = 25$ °C, $V_{GS} = -5 / +15 V$	173					
Continuous Forward Current	l _D	$T_C = 100$ °C, $V_{GS} = -5 / +15 V$	122	Α				
		$T_C = 135^{\circ}C$, $V_{GS} = -5 / +15 V$	89					
Pulsed Drain Current	I _{D(pulse)}	$t_P \le 3\mu s$, D $\le 1\%$, V_{GS} = 15 V, Note 1	400	Α				
Power Dissipation	P_D	$T_c = 25^{\circ}C$	703	W	Note 2			
Non-Repetitive Avalanche Energy	E _{AS}	L = 1.0 mH, I _{AS} = 50.0 A	1204	mJ				
Operating and Storage Temperature	T_j , T_{stg}		-55 to 175	°C				



Electrical Characteristics (At T_C = 25°C Unless Otherwise Stated)

Parameter	Symbol		Values				
		Conditions -	Min.	Тур.	Max.	Unit	Note
Drain-Source Breakdown Voltage	V _{DSS}	$V_{GS} = 0 \text{ V, } I_D = 100 \mu\text{A}$	1200			٧	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 1200 V, V _{GS} = 0 V		1		μA	
Gate Source Leakage Current		V _{DS} = 0 V, V _{GS} = 22 V			100	nA	
	I _{GSS}	$V_{DS} = 0 \text{ V, } V_{GS} = -10 \text{ V}$			-100		
Gate Threshold Voltage	V	$V_{DS} = V_{GS}$, $I_D = 50.0 \text{ mA}$	1.8	2.70		٧	Fig. 9
	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 50.0$ mA, $T_j = 175$ °C		2.05		V	
Transconductance	~ .	$V_{DS} = 10 \text{ V, } I_D = 100 \text{ A}$		48.0		S	Fig. 4
	G fs	$V_{DS} = 10 \text{ V, } I_D = 100 \text{ A, } T_j = 175^{\circ}\text{C}$		54.1			
Drain-Source On-State Resistance		$V_{GS} = 15 \text{ V, } I_D = 100 \text{ A}$		12			Fig. 5-8
	R _{DS(ON)}	V_{GS} = 15 V, I_D = 100 A, T_j = 175°C		18		mΩ	
	T (DS(ON)	$V_{GS} = 18 \text{ V}, I_D = 100 \text{ A}$		10	13.5	11132	
		$V_{GS} = 18 \text{ V, } I_D = 100 \text{ A, } T_j = 175^{\circ}\text{C}$		16			
Input Capacitance	C _{iss}	V _{DS} = 800 V, V _{GS} = 0 V — f = 1 MHz, V _{AC} = 25mV		9335			Fig. 11
Output Capacitance	Coss			284		pF	
Reverse Transfer Capacitance	C _{rss}			22.8			
Coss Stored Energy	Eoss			110		μJ	Fig. 12
Coss Stored Charge	Qoss			412		nC	
Effective Output Capacitance (Energy Related)	$C_{o(er)}$			344		pF	Note 3
Effective Output Capacitance (Time Related)	C _{o(tr)}			515			
Gate-Source Charge	Q_{gs}	$V_{DS} = 800 \text{ V, } V_{GS} = -5 / +15 \text{ V}$		80			Fig. 10
Gate-Drain Charge	Q_{gd}	I _D = 100 A		112		nC	
Total Gate Charge	Q_g	Per IEC607478-4		288			
Internal Gate Resistance	R _{G(int)}	f = 1 MHz, V _{AC} = 25 mV		1.2		Ω	
Turn-On Switching Energy (Body Diode)	E _{On}	_ T_j = 25°C; V_{GS} = -5/+15V; $R_{G(ext)}$ = 2 Ω , I_D = _ 100 A; V_{DD} = 800 V		491			Fig. 18
Turn-Off Switching Energy (Body Diode)	E _{Off}			239		μJ	
Turn-On Delay Time	t _{d(on)}	V _{DD} = 800 V, V _{GS} = -5/+15V		24			Fig. 20
Rise Time	t _r			33		no	
Turn-Off Delay Time	t _{d(off)}	$R_{G(ext)} = 2 \Omega$, $I_D = 100 A$ Timing relative to V _{DS} , Resistive load		22		ns	
Fall Time	t _f			19			

Note 1: Pulse Width t_P Limited by T_{j(max)}

Note 2: Assuming Rth_{JC(max)} = 0.21°C/W

Note 3: $C_{o(er)}$, a lumped capacitance that gives same stored energy as C_{OSS} while V_{DS} is rising from 0 to 800V. $C_{o(tr)}$, a lumped capacitance that gives same charging times as C_{OSS} while V_{DS} is rising from 0 to 800V.

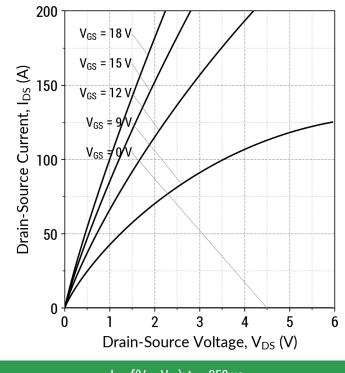




Reverse Diode Characteristics							
Parameter	Symbol	Conditions	Values			Unit	Moto
			Min.	Тур.	Max.	UIIIL	Note
Diode Forward Voltage	V	$V_{GS} = -5 \text{ V, } I_{SD} = 50 \text{ A}$		4.7		V	Fig. 12.14
	V_{SD}	$V_{GS} = -5 \text{ V, } I_{SD} = 50 \text{ A, } T_j = 175^{\circ}\text{C}$		4.2		v Fig.	Fig. 13-14
Continuous Diode Forward Current	ls	$V_{GS} = -5 \text{ V, } T_{c} = 100^{\circ}\text{C}$	69			Α	
Diode Pulse Current	I _{S(pulse)}	V _{GS} = -5 V, Note 1		276		Α	
Reverse Recovery Time	t _{rr}	V_{GS} = -5 V, I_{SD} = 100 A, V_R = 800 V dif/dt = 2000 A/ μ s, T_j = 25°C		37		ns	
Reverse Recovery Charge	Q_{rr}			405		nC	
Peak Reverse Recovery Current	I _{rrm}			28		Α	
Reverse Recovery Time	t _{rr}	V_{GS} = -5 V, I_{SD} = 100 A, V_R = 800 V dif/dt = 2000 A/ μ s, T_j = 175°C		61		ns	
Reverse Recovery Charge	Qrr			1053		nC	
Peak Reverse Recovery Current	I _{rrm}			45		Α	

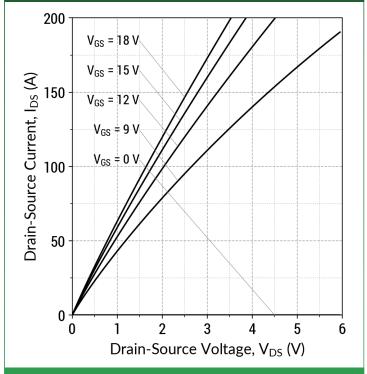


Figure 1: Output Characteristics (T_i = 25°C)



 $I_D = f(V_{DS}, V_{GS}); t_P = 250 \,\mu s$

Figure 2: Output Characteristics (T_i = 175°C)



 $I_D = f(V_{DS}, V_{GS}); t_P = 250 \mu s$

Figure 3: Output Characteristics (V_{GS} = 15 V)

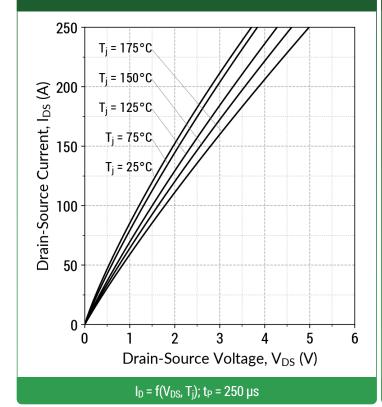


Figure 4: Transfer Characteristics (V_{DS} = 10 V)

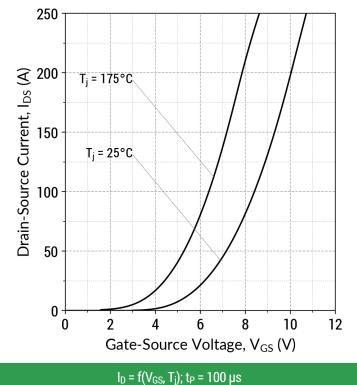
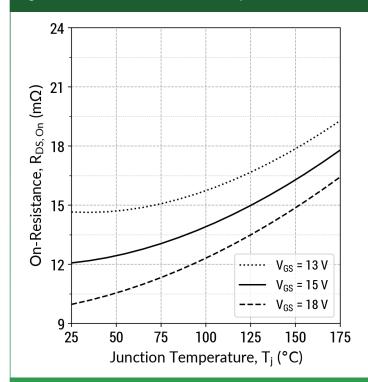


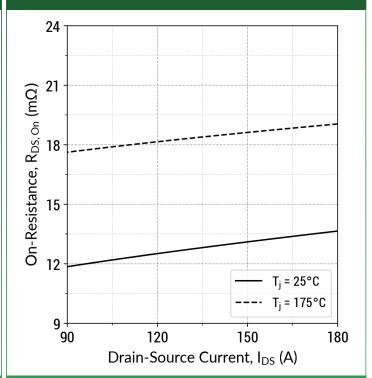


Figure 5: On-State Resistance v/s Temperature



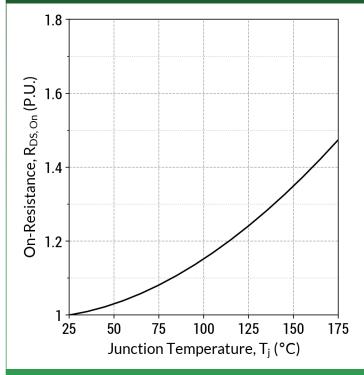
 $R_{DS(ON)} = f(T_i, V_{GS}); t_P = 250 \mu s; I_D = 100 A$

Figure 6: On-State Resistance v/s Drain Current



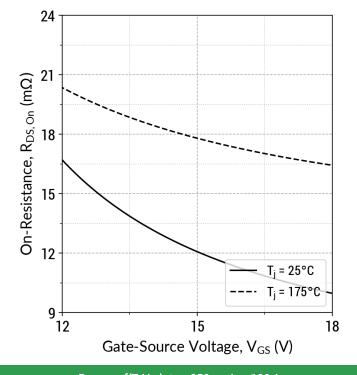
 $R_{DS(ON)} = f(T_i,I_D); t_P = 250 \mu s; V_{GS} = 15 V$

Figure 7: Normalized On-State Resistance v/s Temperature



 $R_{DS(ON)} = f(T_j)$; $t_P = 250 \ \mu s$; $I_D = 100 \ A$; $V_{GS} = 15 \ V$

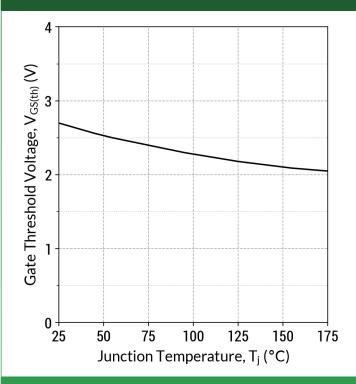
Figure 8: On-State Resistance v/s Gate Voltage



 $R_{DS(ON)} = f(T_j, V_{GS}); t_P = 250 \mu s; I_D = 100 A$

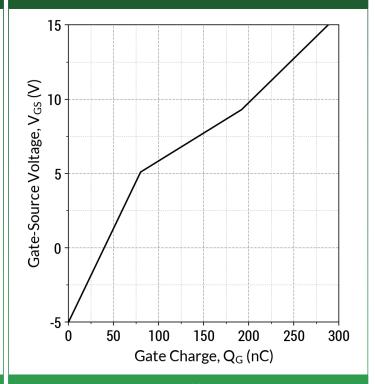






 $V_{GS(th)} = f(T_j); V_{DS} = V_{GS}; I_D = 50.0 \text{ mA}$

Figure 10: Gate Charge Characteristics



 $I_D = 100 \text{ A}$; $V_{DS} = 800 \text{ V}$; $T_c = 25^{\circ}\text{C}$

Figure 11: Capacitance v/s Drain-Source Voltage

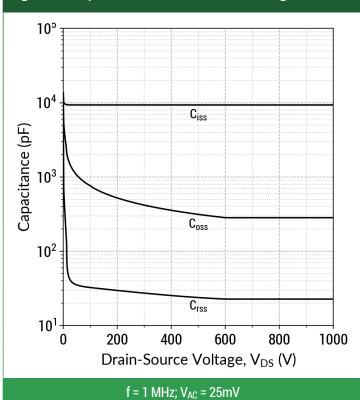
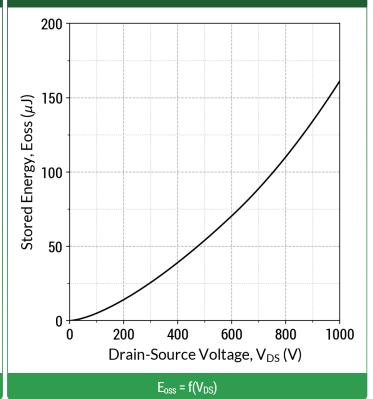


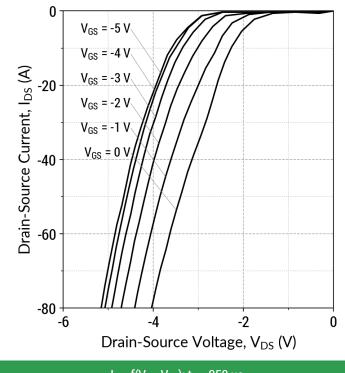
Figure 12: Output Capacitor Stored Energy



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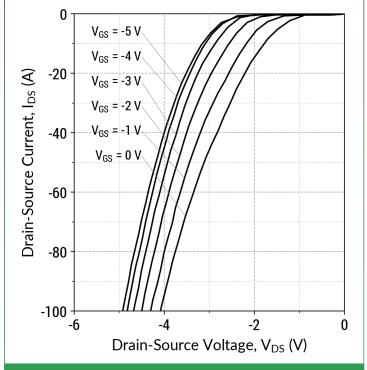


Figure 13: Body Diode Characteristics (T_i = 25°C)



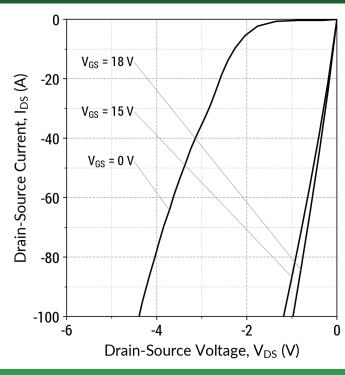
 $I_D = f(V_{DS}, V_{GS}); t_P = 250 \,\mu s$

Figure 14: Body Diode Characteristics (T_i = 175°C)



 $I_D = f(V_{DS}, V_{GS}); t_P = 250 \mu s$

Figure 15: Third Quadrant Characteristics (T_j = 25°C)



 $I_D = f(V_{DS}, V_{GS}); t_P = 250 \,\mu s$

Figure 16: Third Quadrant Characteristics ($T_j = 175$ °C)

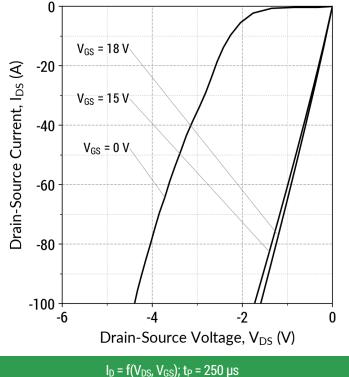
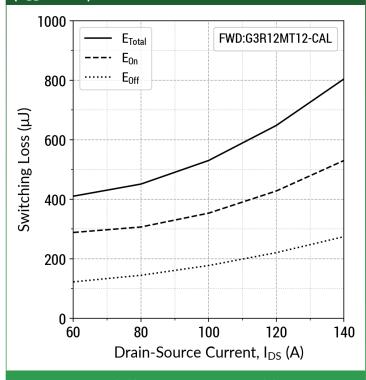


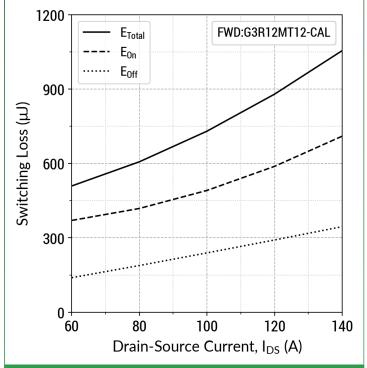


Figure 17: Resistive Switching Energy v/s Drain Current $(V_{DD} = 600V)$



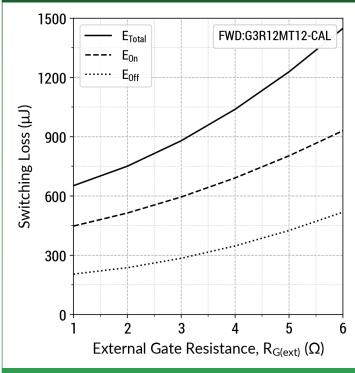
 T_{j} = 25°C; V_{GS} = -5/+15V; $R_{G(ext)}$ = 2 Ω

Figure 18: Resistive Switching Energy v/s Drain Current $(V_{DD} = 800V)$



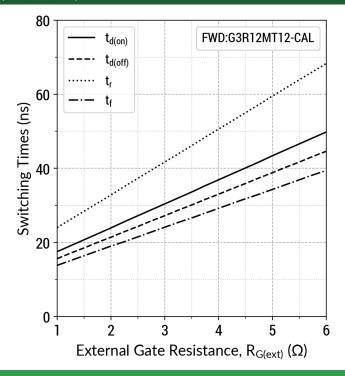
 $T_j = 25$ °C; $V_{GS} = -5/+15V$; $R_{G(ext)} = 2 \Omega$

Figure 19: Resistive Switching Energy v/s $R_{G(ext)}$ (V_{DD} = 800V)



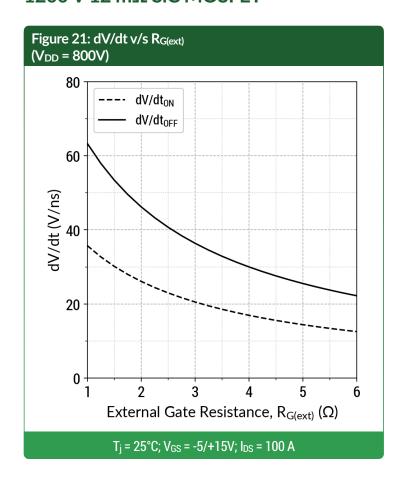
 $T_j = 25$ °C; $V_{GS} = -5/+15V$; $I_{DS} = 100$ A

Figure 20: Switching Time v/s R_{G(ext)} (V_{DD} = 800V)



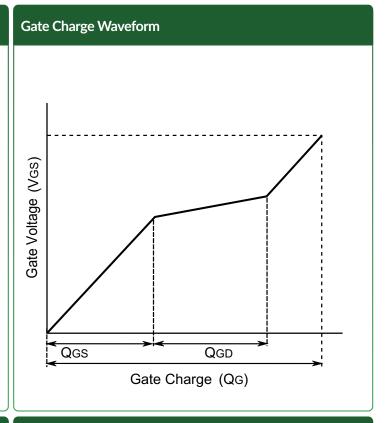
 $T_i = 25$ °C; $V_{GS} = -5/+15$ V; $I_{DS} = 100$ A

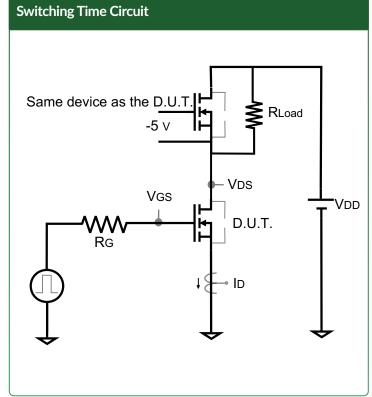


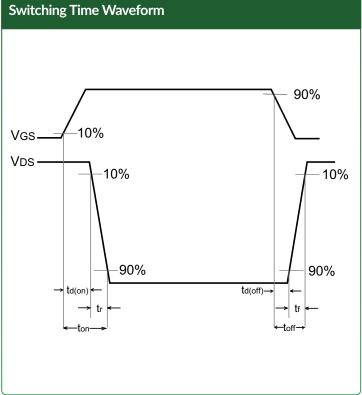




Gate Charge Circuit VDS D.U.T RLoad VDD VDD

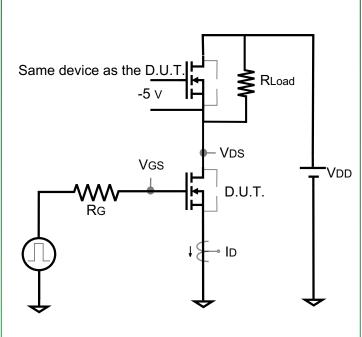


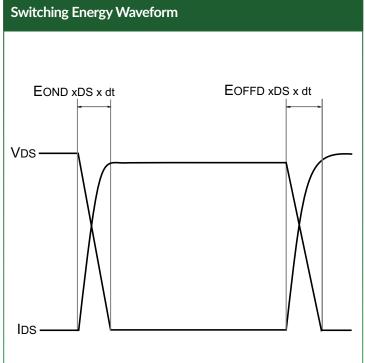




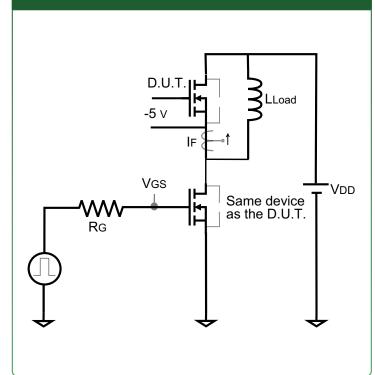


Switching Energy Circuit

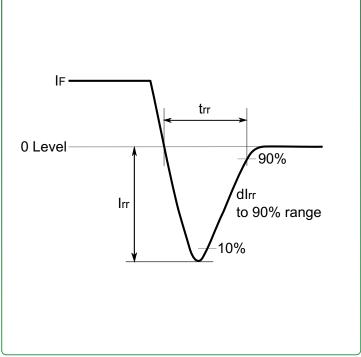




Reverse Recovery Circuit



Reverse Recovery Waveform





Mechanical Parameters

This information is confidential, please contact sales@genesicsemi.com to learn more.

Chip Dimensions

This information is confidential, please contact sales@genesicsemi.com to learn more.

NOTE

- 1. CONTROLLED DIMENSION IS MILLIMETER.
- 2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS.



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Compliance

RoHS Compliance

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS 2), as adopted by EU member states on January 2, 2013 and amended on March 31, 2015 by EU Directive 2015/863. RoHS Declarations for this product can be obtained from your GeneSiC representative.

REACH Compliance

REACH substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact a GeneSiC representative to insure you get the most up-to-date REACH SVHC Declaration. REACH banned substance information (REACH Article 67) is also available upon request.

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Related Links

SPICE Models: https://www.genesicsemi.com/sic-mosfet/G3R12MT12-CAL/G3R12MT12-CAL_SPICE.zip
 PLECS Models: https://www.genesicsemi.com/sic-mosfet/G3R12MT12-CAL/G3R12MT12-CAL_PLECS.zip
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Gate Driver Reference: https://www.genesicsemi.com/technical-support
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Reliability: https://www.genesicsemi.com/reliability
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 Quality Manual: https://www.genesicsemi.com/guality

Revision History

Rev 23/Feb: Updated with Most Recent Data

Supersedes: Rev 21/Aug, Rev 22/Nov, Rev 22/Nov



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